


<b>Search Notes</b>  	<b>Application/Control No.</b>  10535117	<b>Applicant(s)/Patent Under Reexamination</b>  RICHTER ET AL.
	<b>Examiner</b>  Kezhen Shen	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner
369	59.23	12/4/2008	KS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - Text Search (see attachment)	12/4/2008	KS
Consulted Wayne Young	12/4/2008	KS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner, Art Unit 2627